Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/042,248	RAGIL ET AL.
Examiner	Art Unit
Tam M. Nguyen	1764

	SEARCHED			
Class	Subclass	Date	Examiner	
208	134	6/22/2005	TN	
585	820	6/22/2005	TN	
	<u> </u>			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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(INCLUDING	ARCH NOTE SEARCH S)
		DATE	EXMR
EAST		6/21/2005	TN
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